

FCC

EMC

TEST REPORT

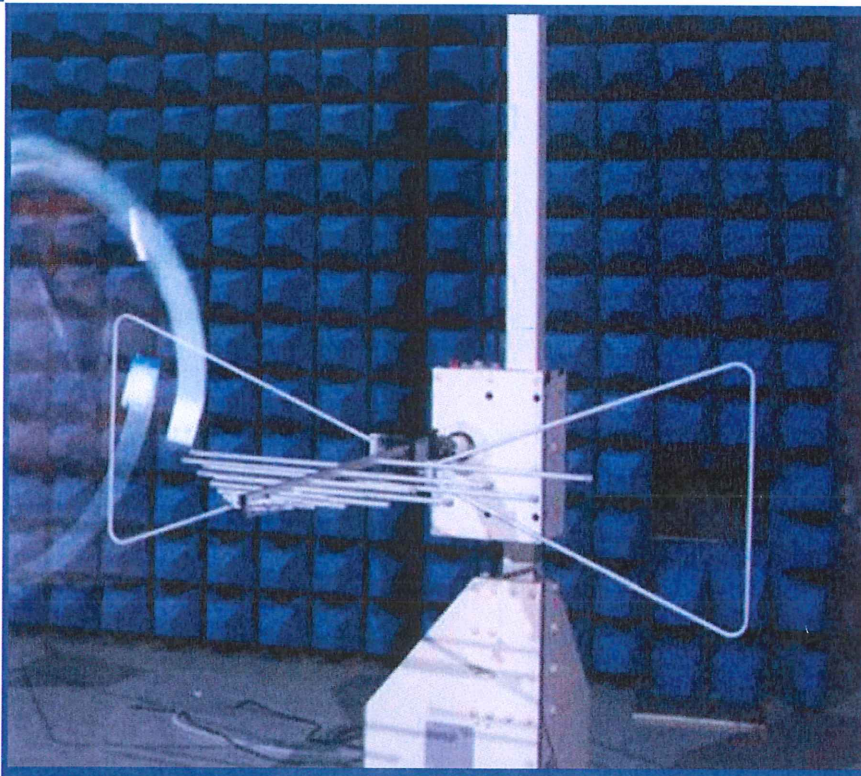
ISSUED BY
Shenzhen BALUN Technology Co., Ltd.



FOR
3G PERS

ISSUED TO
IdentiFind, LLC

1504 Penny Ln. Keller, TX 76248 USA.



Tested by:

Xia Long
Xia Long
(Engineer)

Date

Nov. 12, 2018

Approved by:

Wei Yanquan
Wei Yanquan
(Chief Engineer)

Date

Nov. 12, 2018

Report No.: BL-SZ1870405-401

EUT Name: 3G PERS

Model Name: IF-3G

Brand Name: IdentiFind

Test Standard: 47 CFR Part 15 Subpart B

FCC ID: 2AMCHIF3G

Test Conclusion: Pass

Test Date: Jul. 26, 2018 ~ Oct. 31, 2018

Date of Issue: Nov. 12, 2018

NOTE: This test report of test results only related to testing samples, which can be duplicated completely for the legal use with the approval of the applicant; it shall not be reproduced except in full, without the written approval of Shenzhen BALUN Technology Co., Ltd. Any objections should be raised within thirty days from the date of issue. To validate the report, please contact us.

Revision History

Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Nov. 12, 2018</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co.,Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100
Fax Number	+86 755 6182 4271

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co.,Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 11524A-1. The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196. The laboratory is a testing organization accredited by American Association for Laboratory Accreditation(A2LA) according to ISO/IEC 17025.The accreditation certificate is 4344.01. The laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L6791.
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

1.3 Laboratory Condition

Ambient Temperature	20°C to 25°C
Ambient Relative Humidity	45% to 55%
Ambient Pressure	100 kPa to 102 kPa

1.4 Announce

- (1) The test report refer to the BALUN report mode v6.7.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	IdentiFind, LLC
Address	1504 Penny Ln. Keller, TX 76248 USA.

2.2 Manufacturer Information

Manufacturer	Huizhou Tendetel Industrial Develoment Co., Ltd.
Address	14D, Heqing Business building, Dongping District, Donghu West Road No.168, Huizhou City, Guangdong Province, China.

2.3 Factory Information

Factory	Huizhou Tendetel Industrial Develoment Co., Ltd.
Address	14D, Heqing Business building, Dongping District, Donghu West Road No.168, Huizhou City, Guangdong Province, China.

2.4 General Description for Equipment under Test (EUT)

EUT Name	3G PERS
Model Name Under Test	IF-3G
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	V 215
Software Version	215 V1.00
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.5 Ancillary Equipment

Ancillary Equipment	Charger	
	Brand Name	MINGXIN
	Model No.	MX18W1-0503000V
	Rated Input	100-240 V~, 0.5 A, 50/60 Hz
	Rated Output	5 V=, 3A

2.6 Technical Information

Network and Wireless connectivity	2G Network GSM/GPRS 850 MHz/1900 MHz; 3G Network WCDMA Band 2/5; FSM 315MHz RX only
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3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	FCC 47 CFR Part 15 Subpart B (10-1-17 Edition)	Unintentional Radiators
2	ANSI C63.4-2014	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low- Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

3.2 Verdict

No.	Description	FCC Rule	Test Verdict	Result
1	Radiated Emission	15.109	Pass	Annex A .1
2	Conducted Emission, AC Ports	15.107	Pass	Annex A .2

3.3 Test Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions (9 kHz-30 MHz)	3.23 dB
Radiated emissions (30 MHz-1 GHz)	4.30 dB
Radiated emissions (1 GHz-18 GHz)	4.81 dB
Radiated emissions (18 GHz-40 GHz)	5.71 dB

4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

Environment Parameter	Selected Values During Tests			
	Temperature	Voltage	Relative Humidity	Ambient Pressure
Normal Temperature, Normal Voltage (NTNV)	23°C to 25°C	AC 120 V/60 Hz	50% to 55%	100 kPa to 102 kPa

4.2 Test Equipment List

Radiated Emission Test For Frequency Below 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWA RZ	ESRP	101036	2018.06.13	2019.06.12	☒
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9163	9163-977	2017.07.22	2019.07.21	☒
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	9120D-1600	2018.07.11	2020.07.10	☐
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2019.02.20	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

Radiated Emission Test For Frequency Above 1 GHz						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2017.11.08	2018.11.07	☒
Test Antenna- Bi-Log	SCHWARZBECK	VULB 9163	9163-624	2017.07.22	2019.07.21	☐
Test Antenna- Horn	SCHWARZBECK	BBHA 9120D	9120D-1148	2018.07.11	2020.07.10	☒
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2019.02.20	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

Conducted Emission Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
EMI Receiver	ROHDE&SCHWA RZ	ESRP	101036	2018.06.13	2019.06.12	☒
LISN	SCHWARZBECK	NSLK 8127	8127-687	2018.06.13	2019.06.12	☒
LISN	SCHWARZBECK	NNLK 8129	8129-462	2017.11.08	2018.11.07	☐
ISN	TESEQ	ISN T800	34449	2017.12.05	2018.12.04	☐
Shielded Enclosure	ChangNing	CN-130701	130703	N/A	N/A	☒
Test Software	BALUN	BL410_E	V18.626	--	--	☒

4.3 Test Enclosure list

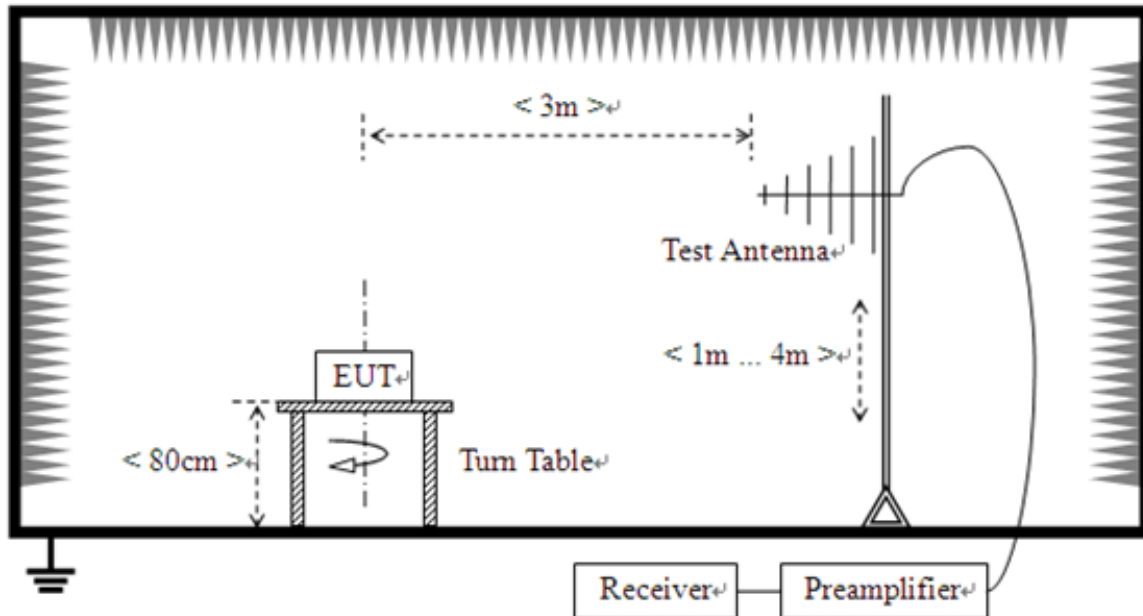
Description	Manufacturer	Model	Serial No.	Length	Description	Use
PC	Dell	015K3N	N/A	N/A	Special Handled	☐
Laptop	Apple	A1465	N/A	N/A	N/A	☐
Printer	HP	DESKJET 1000	N/A	N/A	N/A	☐
Keyboard	Logitech	Y-BP62a	N/A	N/A	N/A	☐
Mouse	Logitech	M100	N/A	N/A	N/A	☐
USB disk	Kingston	N/A	N/A	N/A	N/A	☐
TF Card	Kingston	N/A	N/A	N/A	N/A	☐
VGA Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
HDMI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
DVI Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
Coaxial video cable	N/A	N/A	N/A	2.0 m	Shielded with core	☐
iPhone	Apple	A1586	N/A	N/A	N/A	☐
Phone	MI	M4	N/A	N/A	N/A	☐
Bluetooth Earphone	SAMSUNG	Gear Circle	N/A	N/A	N/A	☐
Wireless Communication s Test Set	R&S	CMW500	142028	N/A	Cal. Due 2018.06.11	☐
WIFI Router	TP-LINK	TL-WDR7500	N/A	N/A	N/A	☐
Earphone	N/A	OPPO	N/A	1.1 m	N/A	☐
Car Battery	Camel	55530	N/A	N/A	12 V/55 Ah	☐
Artificial load	N/A	N/A	N/A	N/A	2.5 Ω /100 W	☐
Artificial load	N/A	N/A	N/A	N/A	5 Ω /100 W	☐
Electronic Load	ITECH	IT8511	N/A	N/A	N/A	☐
USB Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐
DC Power Supply	ITECH	IT6863A	60001401068 7210006	N/A	N/A	☐
LCD Monitor	SAMSUNG	UA32C4000P	N/A	N/A	N/A	☐
LCD Monitor	Dell	U241HB	N/A	N/A	N/A	☐
RJ45 Cable	N/A	N/A	N/A	1.5 m	Shielded with core	☐

4.4 Test Configurations

Test Configurations (TC) No.	Description
TC01	<u>The GSM 850 Link Test Mode</u> FSK 315MHz receiving + GSM 850 Link + Adapter + Battery
TC02	<u>The GPRS 850 Link Test Mode</u> FSK 315MHz receiving + EDGE 850 Link + Adapter + Battery
TC03	<u>The GSM 1900 Link Test Mode</u> FSK 315MHz receiving + GSM 1900 Link + Adapter + Battery
TC04	<u>The GPRS 1900 Link Test Mode</u> FSK 315MHz receiving + EDGE 1900 Link + Adapter + Battery
TC05	<u>The WCDMA 850 Link Test Mode</u> FSK 315MHz receiving + WCDMA 850 Link + Adapter + Battery
TC06	<u>The WCDMA 1900 Link Test Mode</u> FSK 315MHz receiving + WCDMA 1900 Link + Adapter + Battery

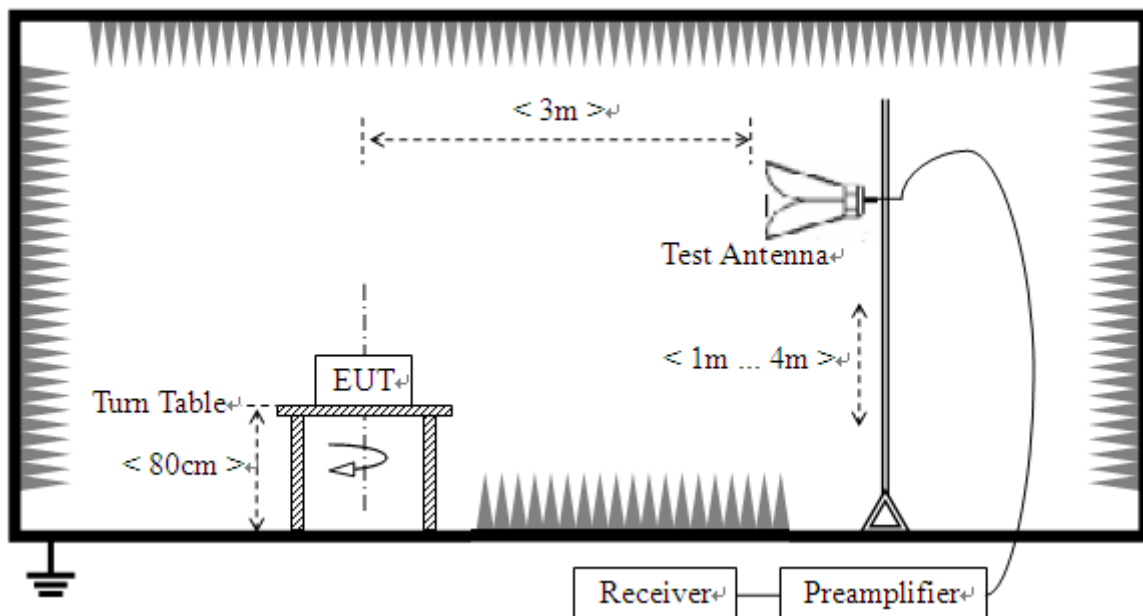
4.5 Test Setups

Test Setup 1



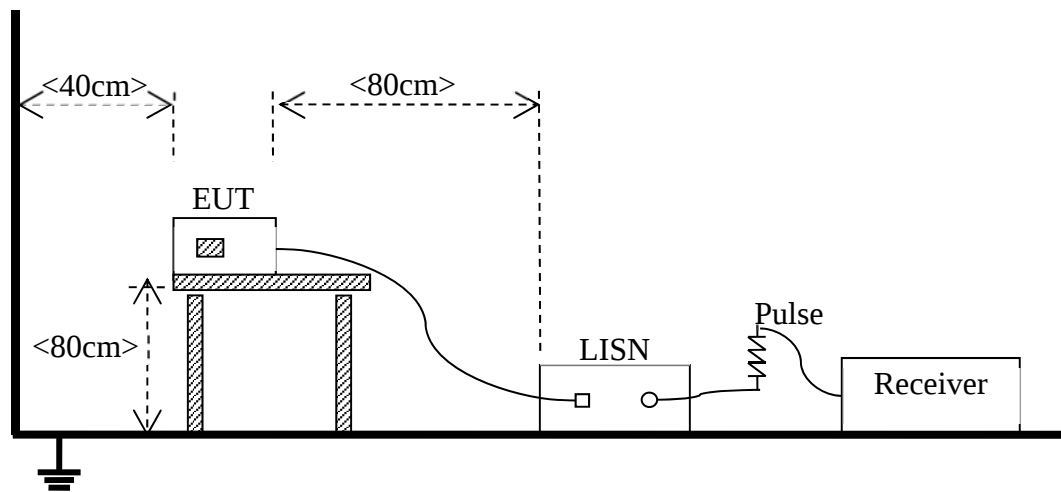
(For Radiated Emission Test (30 MHz-1 GHz))

Test Setup 2



(For Radiated Emission Test (above 1 GHz))

Test Setup 3



(For Conducted Emission, AC Ports Test)

4.6 Test Conditions

Test Case	Test Conditions	
Radiated Emission	Test Env.	NTNV
	Test Setup	Test Setup 1&2
	Test Configuration	TC01~TC06
Conducted Emission, AC Ports	Test Env.	NTNV
	Test Setup	Test Setup 3
	Test Configuration	TC01~TC06
Note: Based on client request, all normal using modes of the normal function were tested but only the worst test data of the worst mode is reported by this report. The GSM 850 Link Test Mode is the worst mode in this report.		

5 TEST ITEMS

5.1 Emission Tests

5.1.1 Radiated Emission

5.1.1.1 Limit

Frequency range (MHz)	Class B (at 3 m)		Class B (at 10 m)	Class A (at 10 m)	
	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)	Field Strength ($\mu\text{V/m}$)	Field Strength (dB $\mu\text{V/m}$)
30 - 88	100	40	30	90	39
88 - 216	150	43.5	33.5	150	43.5
216 - 960	200	46	36	210	46.4
Above 960	500	54	44	300	49.5

NOTE:

- 1) Field Strength (dB $\mu\text{V/m}$) = $20 \times \log [\text{Field Strength } (\mu\text{V/m})]$.
- 2) In the emission tables above, the tighter limit applies at the band edges.

5.1.1.2 Test Setup

Refer to 4.5 section (test setup 1 to test setup 2) for radiated emission test, the photo of test setup please refer to ANNEX B.

5.1.1.3 Test Procedure

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

An initial pre-scan was performed in the chamber using the EMI Receiver in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by Bi-Log antenna with 2 orthogonal polarities.

5.1.1.4 Test Result

Please refer to ANNEX A.1.

NOTE:

1. Results (dB $\mu\text{V/m}$) = Reading (dB μV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Amplifier Gain (dB)

3. Over limit = Results – Limit.

5.1.2 Conducted Emission

5.1.2.1 Test Limit

Frequency range (MHz)	Class A	
	Quasi-peak (dBμV)	Average (dBμV)
0.15 - 0.50	79	66
0.50 - 30	73	60

Frequency range (MHz)	Class B	
	Quasi-peak (dBμV)	Average (dBμV)
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- 1) The lower limit shall apply at the band edges.
- 2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50 MHz.

5.1.2.2 Test Setup

Refer to 4.5 section test (test setup 3) for conducted emission, the photo of test setup please refer to ANNEX B.

5.1.2.3 Test Procedure

The EUT is connected to the power mains through a LISN which provides 50 Ω/50 μH of coupling impedance for the measuring instrument. The test frequency range is from 150 kHz to 30 MHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels that are more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.1.2.4 Test Result

Please refer to ANNEX A.2.

NOTE:

1. Results (dBuV/m) = Reading (dBuV) + Factor (dB/m)

The reading level is calculated by software which is not shown in the sheet

2. Factor = Insertion loss + Cable loss

3. Over limit = Results – Limit.

ANNEX A TEST RESULTS

A.1 Radiated Emission

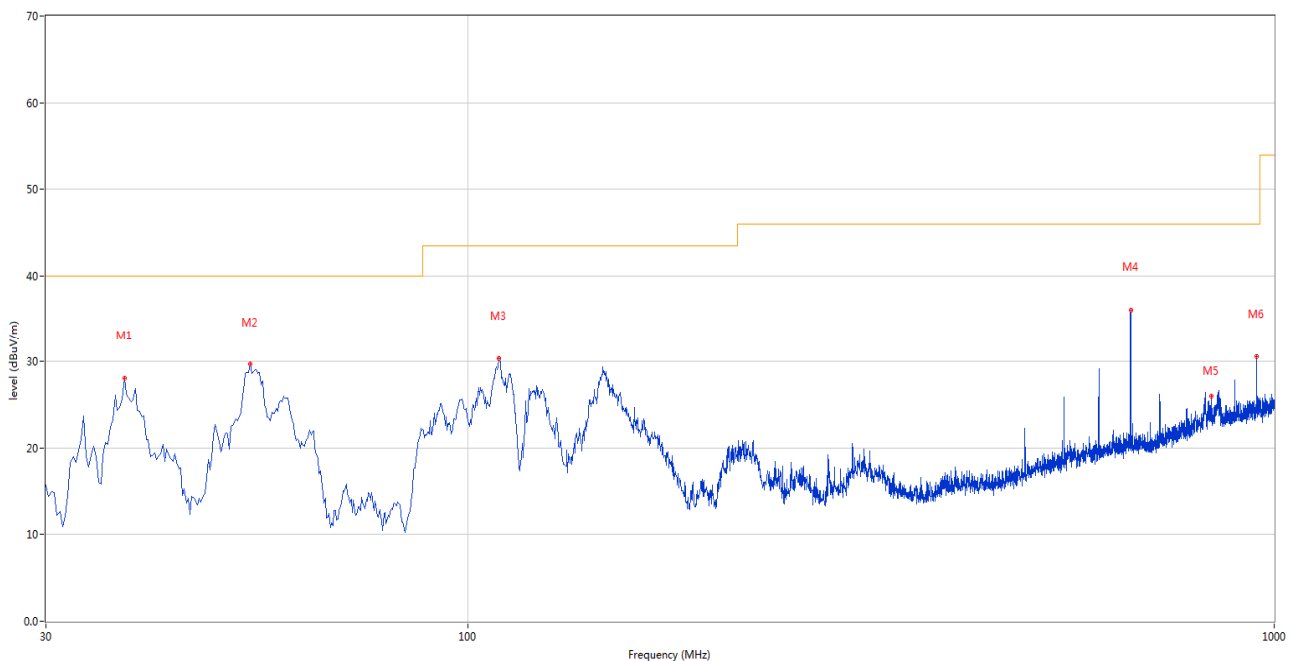
Note 1: The symbol of “--” in the table which means not application.

Note 2: For the test data above 1 GHz, according the ANSI C63.4-2014, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Test Data and Plots

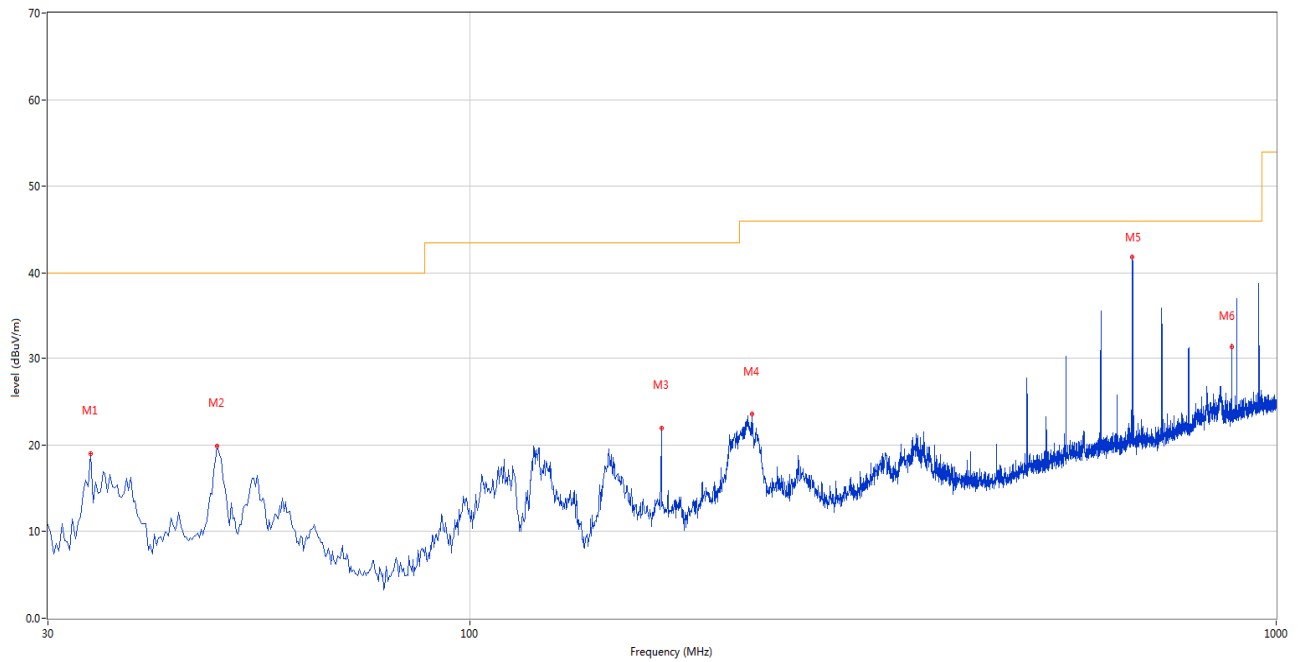
The GSM 850 Link Test Mode

A.1.1 Test Antenna Vertical, 30 MHz – 1 GHz



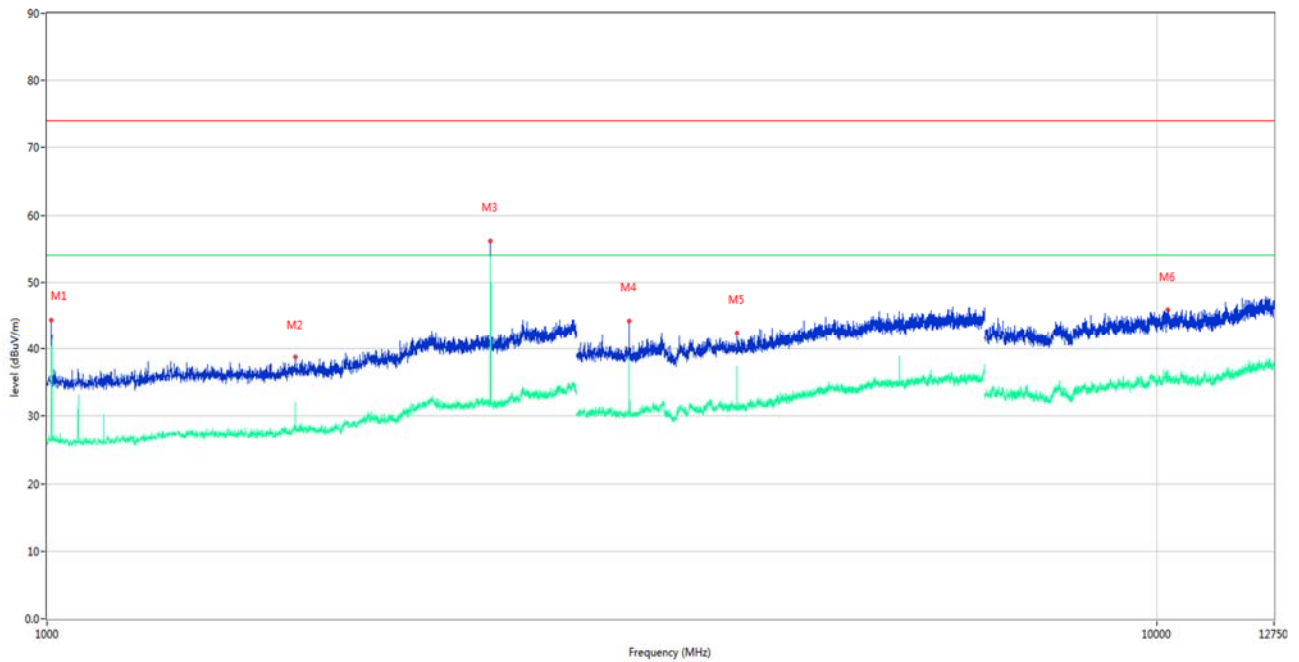
No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Over Limit (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	37.517	28.12	-25.07	40.0	-11.88	Peak	136.20	100	V	Pass
2	53.765	29.66	-23.48	40.0	-10.34	Peak	260.80	100	V	Pass
3	109.298	30.41	-24.53	43.5	-13.09	Peak	360.70	100	V	Pass
4	663.895	36.03	-13.42	46.0	-9.97	Peak	331.00	100	V	Pass
5	836.828	25.95	-8.93	46.0	-20.05	Peak	331.60	200	V	N/A
6	951.742	30.58	-9.73	46.0	-15.42	Peak	205.70	200	V	Pass

A.1.2 Test Antenna Horizontal, 30 MHz – 1 GHz



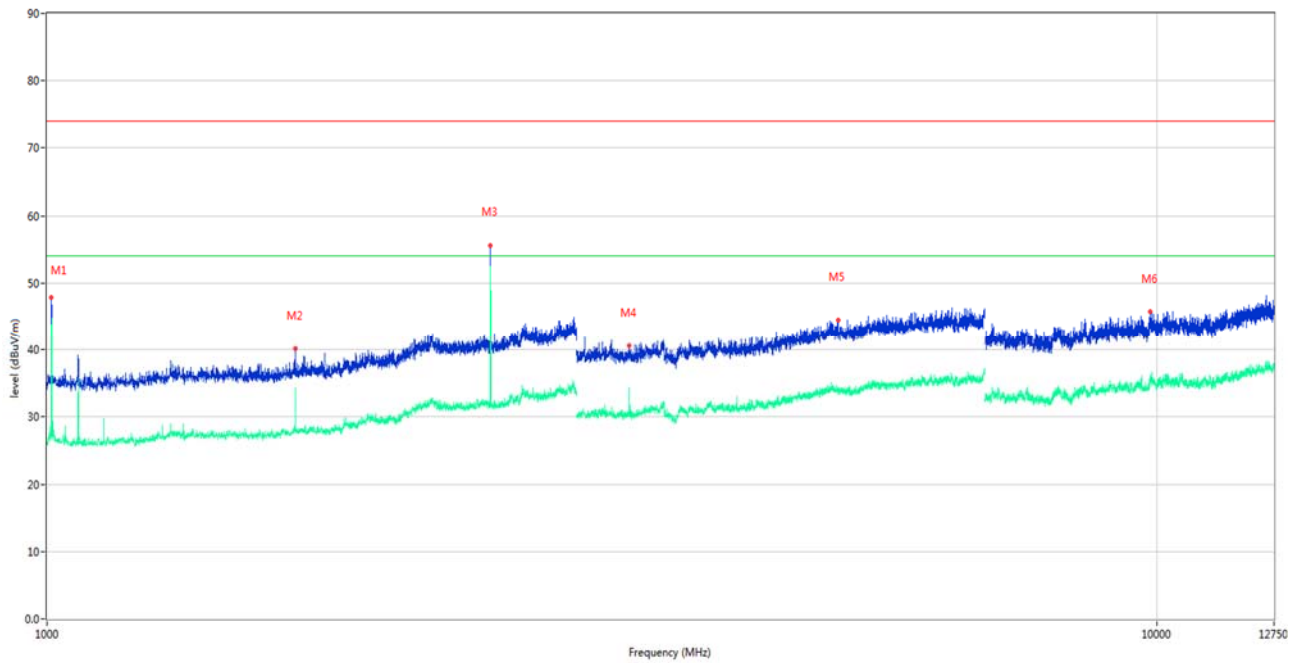
No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Over Limit (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	33.880	19.02	-26.58	40.0	-20.98	Peak	0.00	200	H	Pass
2	48.672	19.89	-23.19	40.0	-20.11	Peak	172.80	200	H	Pass
3	172.833	21.96	-26.74	43.5	-21.54	Peak	218.00	200	H	Pass
4	224.000	23.54	-24.31	46.0	-22.46	Peak	281.30	100	H	Pass
5	663.653	41.84	-13.43	46.0	-4.16	Peak	0.00	200	H	Pass
6	881.417	31.31	-10.61	46.0	-14.69	Peak	97.50	100	H	N/A

A.1.3 Test Antenna Vertical, 1 GHz – 12.75 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Over Limit (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1**	1009.000	27.36	-17.05	54.0	-26.64	AV	165.40	100	V	Pass
1	1009.000	44.32	-17.05	74.0	-29.68	Peak	165.40	100	V	Pass
2**	1673.500	32.01	-15.41	54.0	-21.99	AV	308.40	100	V	N/A
2	1673.500	38.70	-15.41	74.0	-35.30	Peak	308.40	100	V	N/A
3**	2509.500	46.00	-11.51	54.0	-8.00	AV	21.60	100	V	N/A
3	2509.500	56.22	-11.51	74.0	-17.78	Peak	21.60	100	V	N/A
4**	3346.000	30.66	-10.84	54.0	-23.34	AV	87.20	100	V	N/A
4	3346.000	44.24	-10.84	74.0	-29.76	Peak	87.20	100	V	N/A
5**	4183.000	31.91	-8.56	54.0	-22.09	AV	285.20	100	V	N/A
5	4183.000	42.43	-8.56	74.0	-31.57	Peak	285.20	100	V	N/A
6**	10221.438	36.43	16.37	54.0	-17.57	AV	105.00	100	V	Pass
6	10221.438	45.93	16.37	74.0	-28.07	Peak	105.00	100	V	Pass

A.1.4 Test Antenna Horizontal, 1 GHz – 12.75 GHz



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Over Limit (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1**	1009.500	42.90	-17.17	54.0	-11.10	AV	243.60	100	H	Pass
1	1009.500	47.91	-17.17	74.0	-26.09	Peak	243.60	100	H	Pass
2**	1673.000	28.95	-15.35	54.0	-25.05	AV	107.40	100	H	N/A
2	1673.000	40.21	-15.35	74.0	-33.79	Peak	107.40	100	H	N/A
3**	2510.000	52.55	-11.47	54.0	-1.45	AV	314.90	100	H	N/A
3	2510.000	55.63	-11.47	74.0	-18.37	Peak	314.90	100	H	N/A
4**	3346.000	30.33	-10.84	54.0	-23.67	AV	95.90	100	H	N/A
4	3346.000	40.58	-10.84	74.0	-33.42	Peak	95.90	100	H	N/A
5**	5165.000	34.09	-6.26	54.0	-19.91	AV	323.10	100	H	Pass
5	5165.000	44.52	-6.26	74.0	-29.48	Peak	323.10	100	H	Pass
6**	9859.188	35.74	16.48	54.0	-18.26	AV	360.00	100	H	Pass
6	9859.188	45.81	16.48	74.0	-28.19	Peak	360.00	100	H	Pass

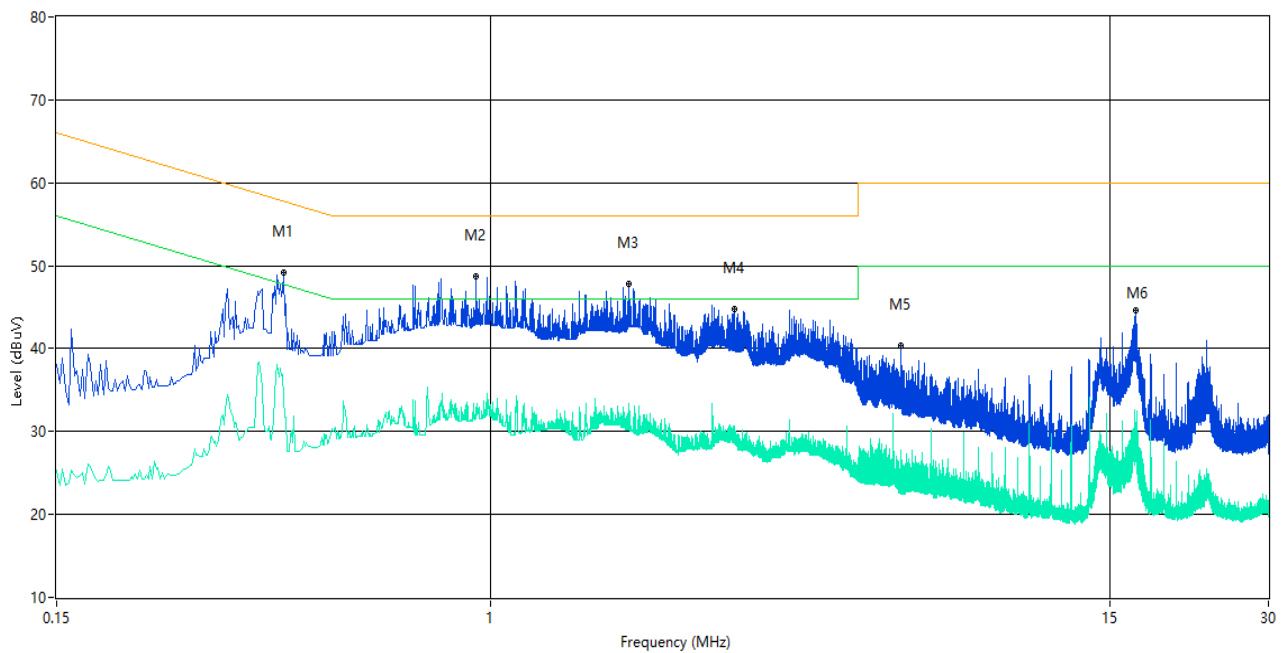
A.2 Conducted Emission

Test Data and Plots

The GSM 850 Link Test Mode

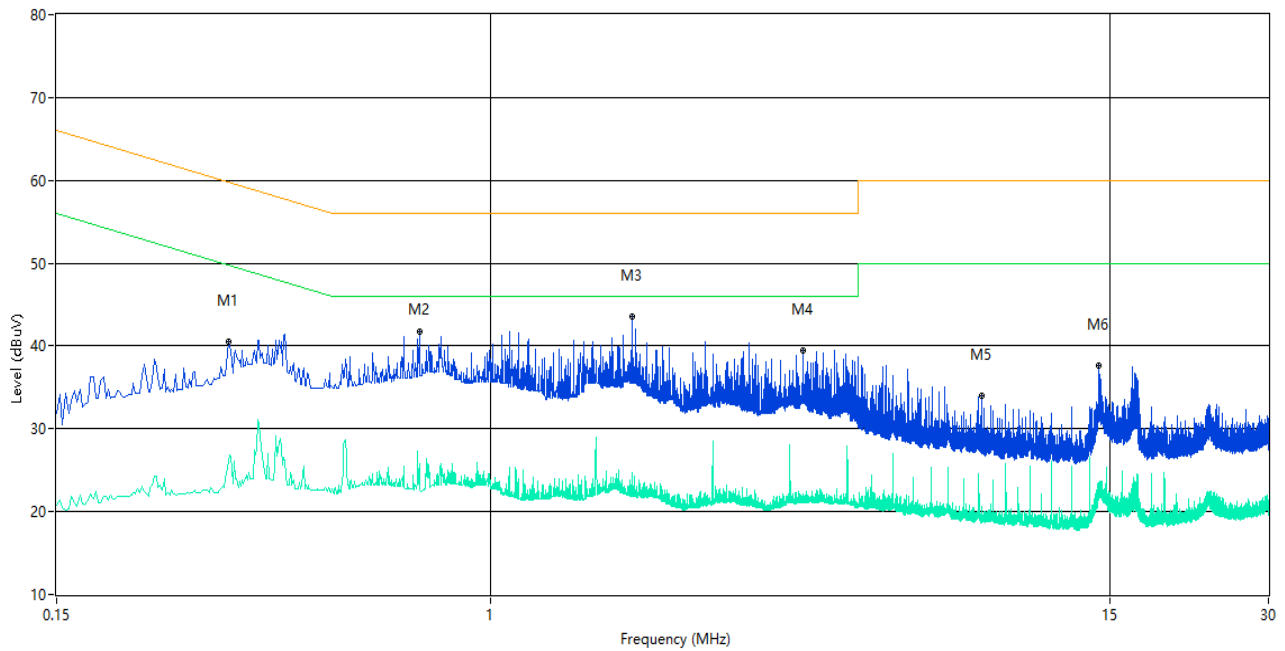
Note: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

A.2.1 L Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Over Limit (dB)	Detector	Line	Verdict
1	0.404	49.1	10.02	57.8	-8.70	Peak	L Line	Pass
1**	0.404	34.1	10.02	47.8	-13.70	AV	L Line	Pass
2	0.940	48.7	10.03	56.0	-7.30	Peak	L Line	Pass
2**	0.940	32.9	10.03	46.0	-13.10	AV	L Line	Pass
3	1.832	47.8	10.05	56.0	-8.20	Peak	L Line	Pass
3**	1.832	33.4	10.05	46.0	-12.60	AV	L Line	Pass
4	2.908	44.7	10.08	56.0	-11.30	Peak	L Line	Pass
4**	2.908	29.6	10.08	46.0	-16.40	AV	L Line	Pass
5	6.000	40.4	10.13	60.0	-19.60	Peak	L Line	Pass
5**	6.000	27.8	10.13	50.0	-22.20	AV	L Line	Pass
6	16.798	44.6	10.22	60.0	-15.40	Peak	L Line	Pass
6**	16.798	31.2	10.22	50.0	-18.80	AV	L Line	Pass

A.2.2 N Phase



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Over Limit (dB)	Detector	Line	Verdict
1	0.318	40.5	10.03	59.8	-19.30	Peak	N Line	Pass
1**	0.318	25.9	10.03	49.8	-23.90	AV	N Line	Pass
2	0.732	41.7	10.03	56.0	-14.30	Peak	N Line	Pass
2**	0.732	25.7	10.03	46.0	-20.30	AV	N Line	Pass
3	1.854	43.6	10.04	56.0	-12.40	Peak	N Line	Pass
3**	1.854	24.8	10.04	46.0	-21.20	AV	N Line	Pass
4	3.926	39.5	10.09	56.0	-16.50	Peak	N Line	Pass
4**	3.926	21.3	10.09	46.0	-24.70	AV	N Line	Pass
5	8.572	34.0	10.15	60.0	-26.00	Peak	N Line	Pass
5**	8.572	19.7	10.15	50.0	-30.30	AV	N Line	Pass
6	14.270	37.6	10.20	60.0	-22.40	Peak	N Line	Pass
6**	14.270	20.8	10.20	50.0	-29.20	AV	N Line	Pass

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ1870405-AE.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL-SZ1870405-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL-SZ1870405-AI.PDF”.

--END OF REPORT--